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FDS7066N7 30V N-Channel PowerTrench[®] MOSFET

General Description

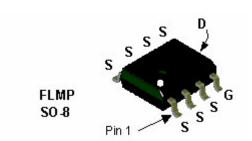
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{DS(ON)}$ in a small package.

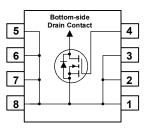
Applications

- Synchronous rectifier
- DC/DC converter

Features

- 23 A, 30 V $R_{DS(ON)} = 4.5 \text{ m}\Omega \textcircled{0} V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 5.5 \text{ m}\Omega \textcircled{0} V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability
- Fast switching
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





Absolute Maximum Ratings T_A=25°C unless otherwise noted

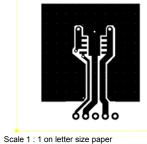
Symbol	Parameter			Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V	
V _{GSS}	Gate-Sourc	e Voltage		±16	V
ID	Drain Current – Continuous		(Note 1a)	23	A
	– Pulsed			60	
P _D	Power Dissipation for Single Operation		n (Note 1a)	3.0	W
			(Note 1b)	1.7	
T _J , T _{STG}	Operating a	Operating and Storage Junction Temperature Range		-55 to +150	°C
Therma	l Charac	teristics			
R _{0JA}	Thermal Resistance, Junction-to-Ambient (Note 1a)		ient (Note 1a)	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)		e (Note 1)	0.5	
Packag	e Markin	g and Ordering I	nformation		
	Marking	Device	Reel Size	Tape width	Quantity
Device					

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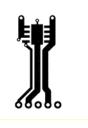
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			1		
BV _{DSS}	Drain–Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		24		mV/°C
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$			1	μA
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 16 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -16 V, V _{DS} = 0 V			-100	nA
On Char	acteristics (Note 2)		•	•	•	•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1	1.5	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-4.3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 V, I_D = 23 A$ $V_{GS} = 4.5 V, I_D = 21 A$ $V_{GS} = 10 V, I_D = 23 A, T_J = 125^{\circ}C$		3.5 4.0 5.0	4.5 5.5 6.3	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 23 \text{ A}$		116		S
Dynamic	Characteristics		•	•	•	•
C _{iss}	Input Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,		4973		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		826		pF
C _{rss}	Reverse Transfer Capacitance			341		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 15 V, I_D = 1 A,$		12	22	ns
tr	Turn–On Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		8	16	ns
t _{d(off)}	Turn–Off Delay Time			85	136	ns
t _f	Turn–Off Fall Time			25	40	ns
Qg	Total Gate Charge	$V_{DS} = 15 V$, $I_{D} = 23 A$,		43	69	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 5.0 V		13		nC
Q _{gd}	Gate–Drain Charge			11		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2.5 A$ (Note 2)		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 23 A,		34.2		nS
Q _{rr}	Diode Reverse Recovery Charge	d _{iF} /d _t = 100 A/μs		40.4		nC

Notes:

1. $R_{0,JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{0,C}$ is guaranteed by design while $R_{0,CA}$ is determined by the user's board design.



a) 40°C/W when mounted on a 1in² pad of 2 oz copper



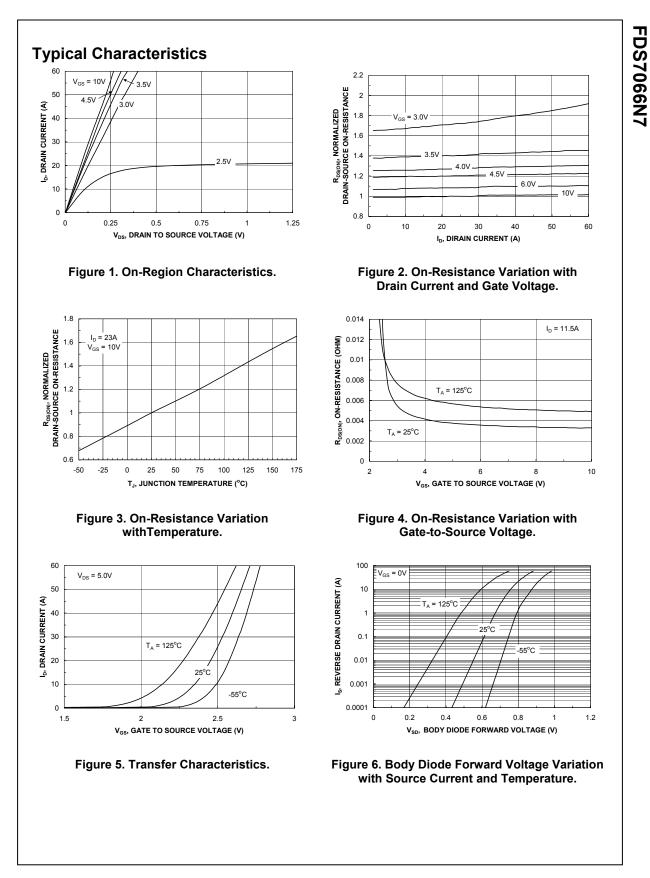
85°C/W when mounted on a minimum pad of 2 oz copper

b)

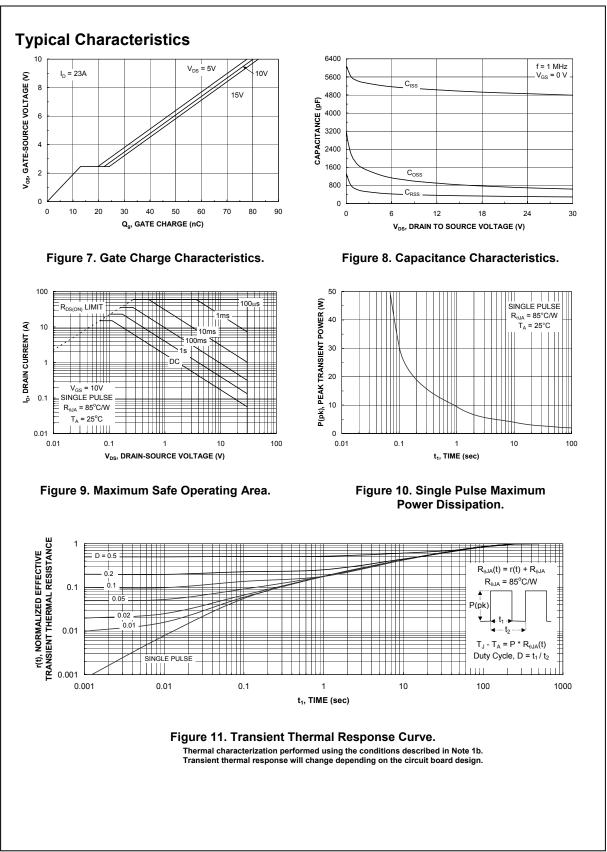
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

FDS7066N7 Rev D3 (W)

FDS7066N7

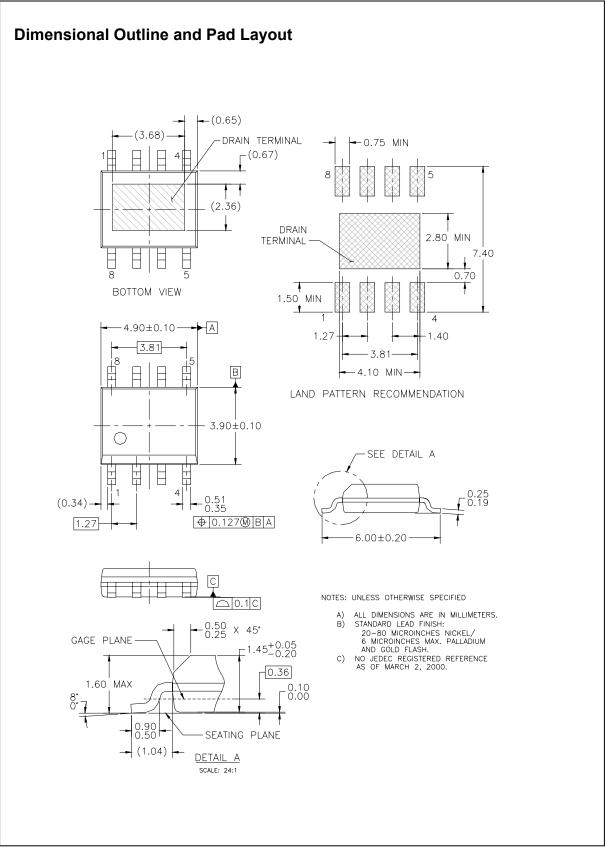


FDS7066N7 Rev D3 (W)



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FDS7066N7



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FDS7066N7 Rev D3 (W)

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